


DT01 d PCT/PTC 24 JAN 2005

Substitute Form PTO-1449 (Modified)  <b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 14603-009US1	Application No. <b>10/521931</b>
	Applicant <b>Helmut Theiler</b>		
	Filing Date	Group Art Unit	

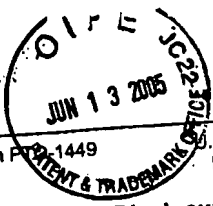
U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
AA	AA	4,668,908	05/26/87	Kazuhisa Aoki et al			
	AB	4,777,379	10/11/88	Danny J. Young			
	AC	4,777,380	10/11/88	Daniel Wathelet			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
AA	AL	0 515 961	05/20/92	EPO			Abstract	
	AM	0 117 198	02/14/84	EPO			Abstract	
	AN	38 13 538	11/02/89	Germany			Abstract	
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature 	Date Considered 8/13/07
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Disclosure Form (PTO-1449)



Substitute Form PTO-1449  
(Modified)

U.S. Department of Commerce  
Patent and Trademark Office

Attorney's Docket No.  
14603-009US1

Application No.  
10/521,931

**Information Disclosure Statement  
by Applicant**  
(Use several sheets if necessary)

Applicant  
**Helmut Theiler**  
Filing Date  
**January 24, 2005**

Group Art Unit

(37 CFR §1.98(b))

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
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	AL							
	AM							
	AN							
	AO							
	AP							

**Other Documents (include Author, Title, Date, and Place of Publication)**

Examiner Initial	Desig. ID	Document
<b>A</b>	AQ	English Translation of International Preliminary Examination Report for application PCT/EP2003/005328.
	AR	
	AS	
	AT	

Examiner Signature

Date Considered

**8/13/07**

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